

VM135D

General Description

The VM135D is a low noise amplifier MMIC operating in the frequency range 8 to 12GHz.

The device has a linear gain of 18dB and a typical noise figure of 1.0dB. Typical operating supply current is only 28mA with a supply voltage at +3V and -3V.

It is manufactured on a PHEMT Technology and is especially suited for radar and for telecommunication applications.

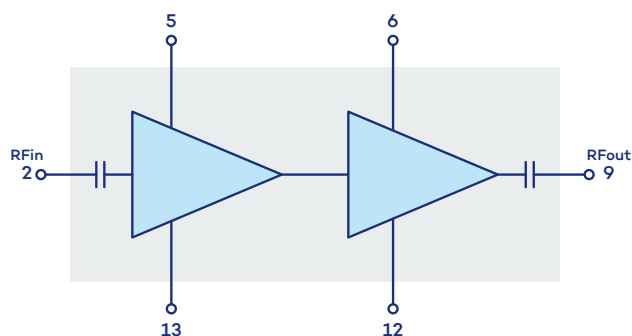
Features

Frequency range	8 – 12GHz
Gain	18dB
Noise Figure	1.0dB
Gain Flatness	+/- 0.7dB
Input Return Loss	-10dB typ.
Output Return Loss	-12dB typ.
Power supply	28mA @V_{DD} = 3V, V_{SS} = -3V
Die size	1.4 x 1.4 x 0.1 (mm)

Applications

- Radar
- Test and measurement
- Telecommunications

Pins Assignment & Functional Block Diagram



Function	Pin number
RF in	2
V _{DD1}	5
V _{DD2}	6
RF out	9
V _{SS2}	12
V _{SS1}	13

Electrical Specifications

Test conditions: unless otherwise noted

- $T_{amb} = +25^{\circ}\text{C}$
- $I_{DD} = I_{DD1} + I_{DD2} = 28\text{mA}$
- $V_{DD} = V_{DD1} = V_{DD2} = +3\text{V}$
- $V_{SS} = V_{SS1} = V_{SS2} = -3\text{V}$

Symbol	Parameter	Min	Typ	Max	Unit
F	Frequency range	8		12	GHz
G	Linear gain		18		dB
ΔG	Small signal gain flatness		± 0.7		dB
NF	Noise Figure		1.0		dB
OP1dB	Output power @1dB compression		7		dBm
P_{SAT}	Saturated Output Power		9		dBm
S11	Input return loss		-10		dB
S22	Output return loss		-12		dB
V_{DD1_2}	Operating supply voltage		+3		V
V_{SS1_2}			-3		V
I_{DD}	Supply current		28		mA

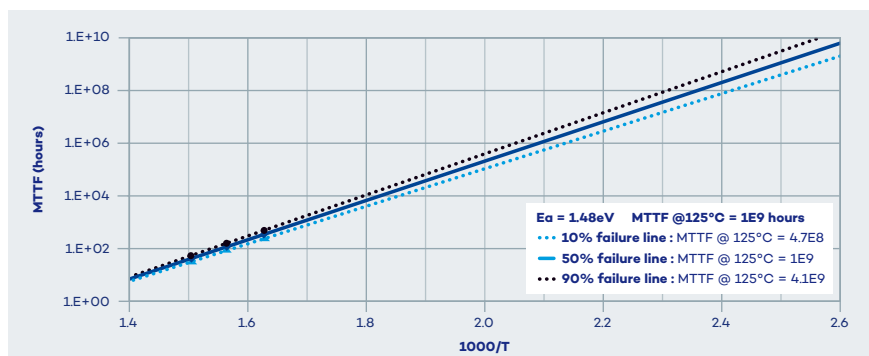
Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Unit
V_{DD1_2}	Voltage Supply		+4	V
V_{SS1_2}		-6	+0.5	V
P_{in}	CW input power		+10	dBm
T_{st}	Storage temperature	-55	+125	$^{\circ}\text{C}$
T_{op}	Operating temperature	-40	+85	$^{\circ}\text{C}$
T_{ch}	Channel temperature		+150	$^{\circ}\text{C}$

Operation of this device above any of these parameters may cause permanent damage.

MTTF (Provided by Foundry)

0.15 μm Low noise pHEMT (PL15-10) vs MTTF Test Arrhenius Plot



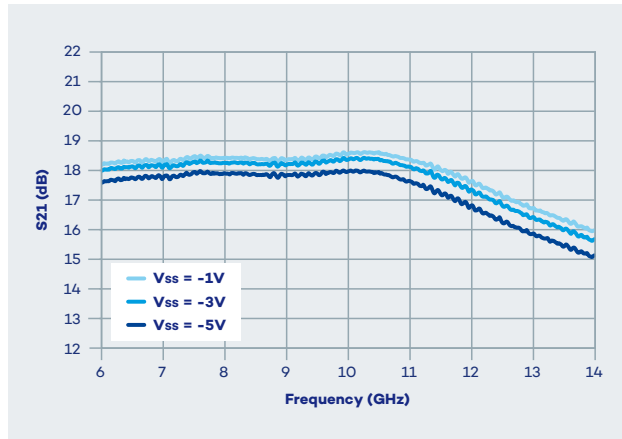
The values shown here are calculated, only to be used as a guideline and represent reliability information under $V_{ds} = +5\text{V}$ and drain current of 267mA/mm.

• Typical Performance (Board Measurements)

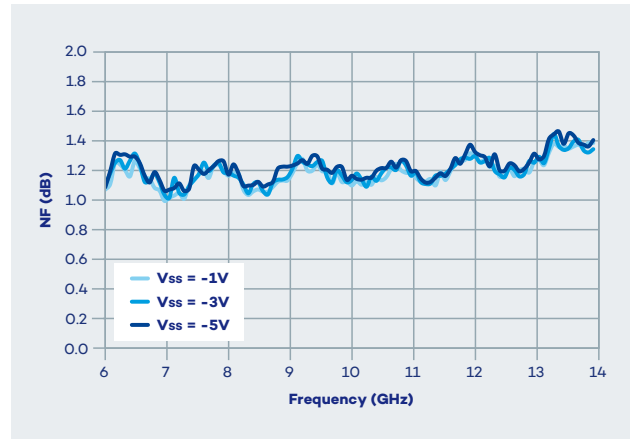
Test conditions: unless otherwise noted

- $T_{amb} = +25^{\circ}\text{C}$
- $V_{DD} = +3\text{V}$
- Typically, $I_{DD} = 28\text{mA}$ @ $V_{SS} = -3\text{V}$

Small Signal Gain vs V_{SS}

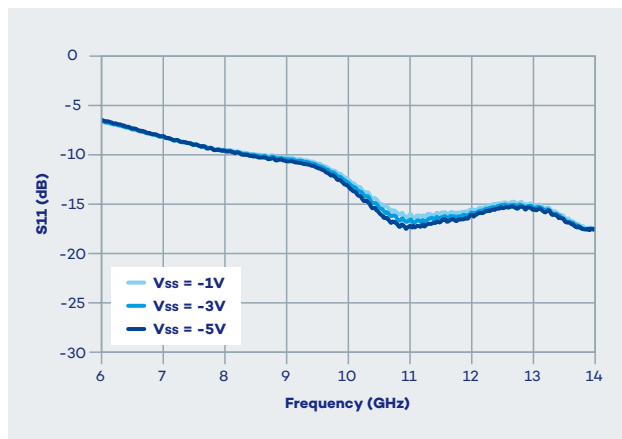


Noise Figure vs V_{SS}

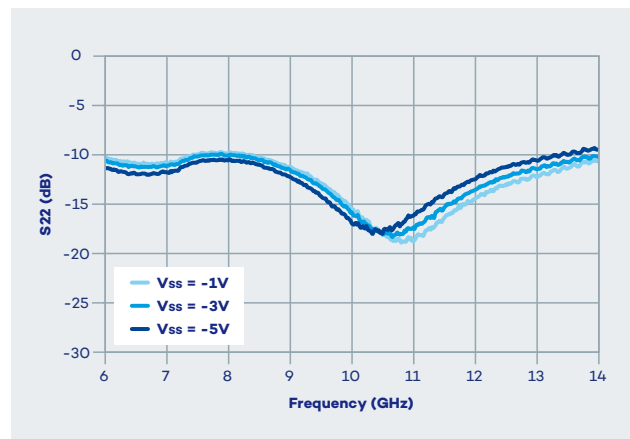


Measurement accuracy for Noise Figure is $\pm 0.2\text{dB}$.

Input Return Loss vs V_{SS}



Output Return Loss vs V_{SS}

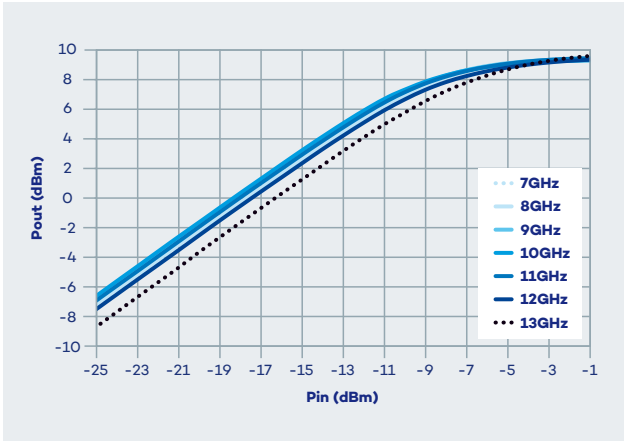


• **Typical Performance**
(Board Measurements)

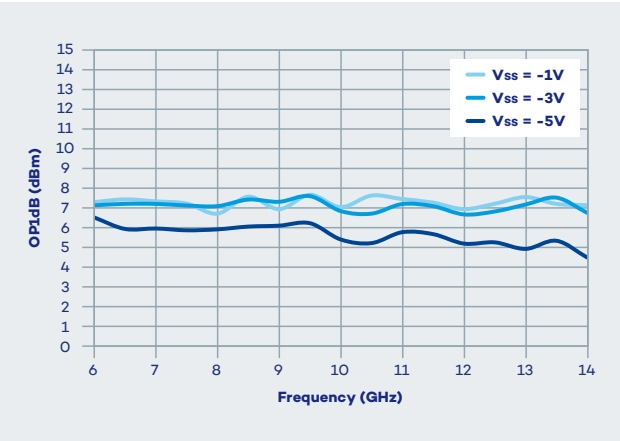
Test conditions: unless otherwise noted

- $T_{amb} = +25^{\circ}C$
- $V_{DD} = +3V$

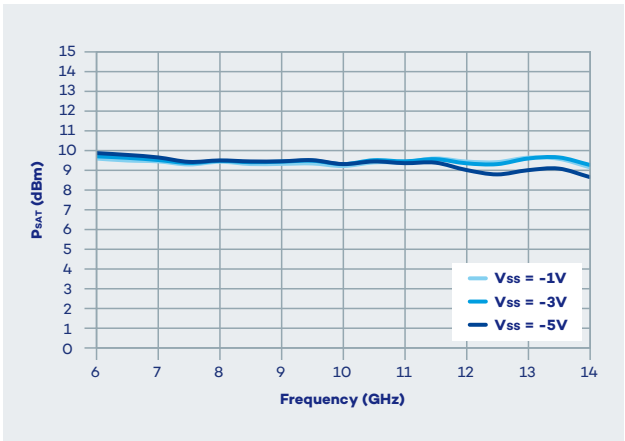
Output Power vs Input Power @ $V_{SS} = -3V$



P1dB vs Frequency vs V_{SS}



P_{SAT} vs Frequency vs V_{SS}



I_{DD} vs V_{SS}

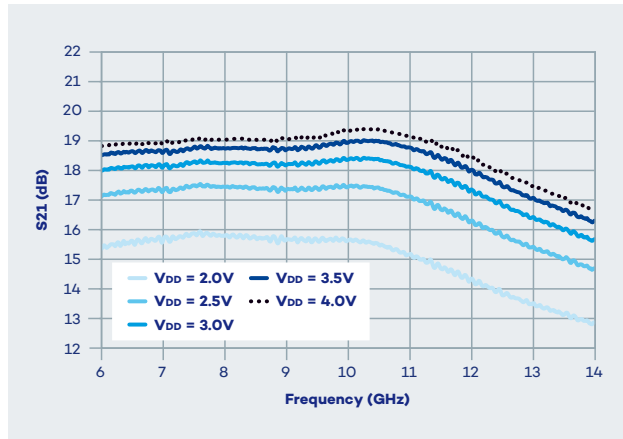
V_{DD}	V_{SS}	I_{DD}
3.0V	-1.0V	31mA
3.0V	-3.0V	28mA
3.0V	-5.0V	24mA

• Typical Performance (Board Measurements)

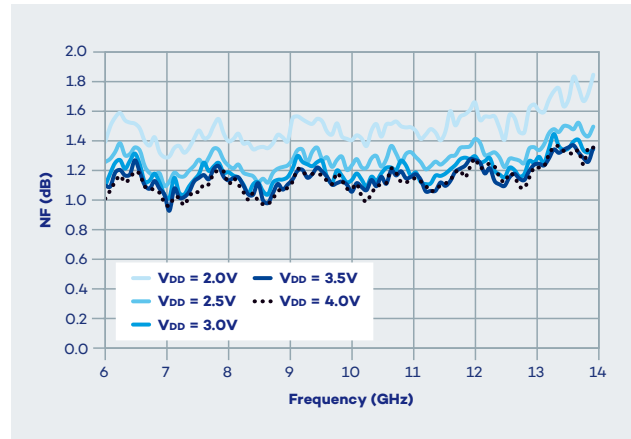
Test conditions: unless otherwise noted

- $T_{amb} = +25^{\circ}\text{C}$
- $V_{SS} = -3\text{V}$
- Typically, $I_{DD} = 28\text{mA}$ @ $V_{DD} = +3\text{V}$

Small Signal Gain vs V_{DD}

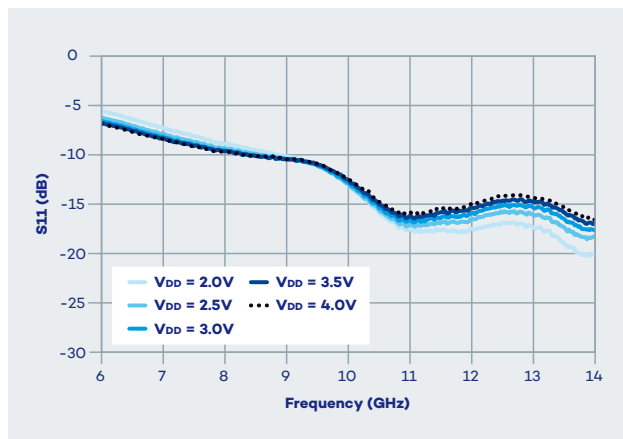


Noise Figure vs V_{DD}

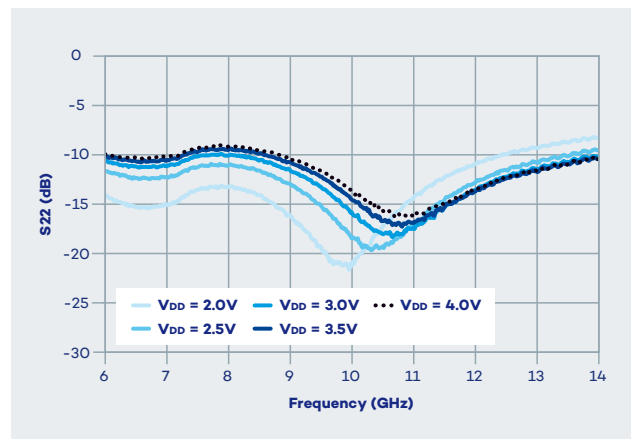


Measurement accuracy for Noise Figure is $\pm 0.2\text{dB}$.

Input Return Loss vs V_{DD}



Output Return Loss vs V_{DD}

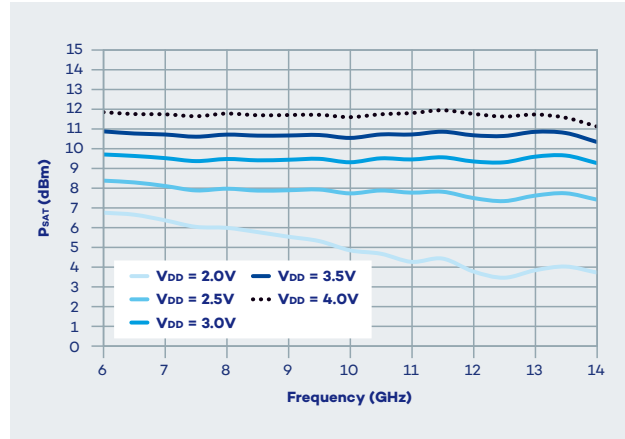


Typical Performance (Board Measurements)

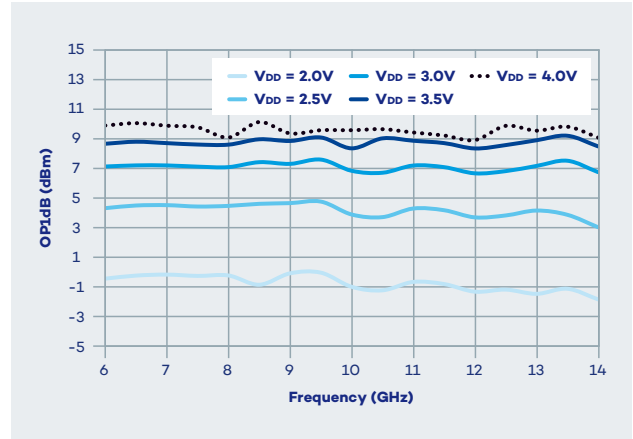
Test conditions: unless otherwise noted

- $T_{amb} = +25^{\circ}\text{C}$
- $V_{SS} = -3\text{V}$

P_{SAT} vs Frequency vs V_{DD}



P_{1dB} vs Frequency vs V_{DD}



I_{DD} vs V_{DD}

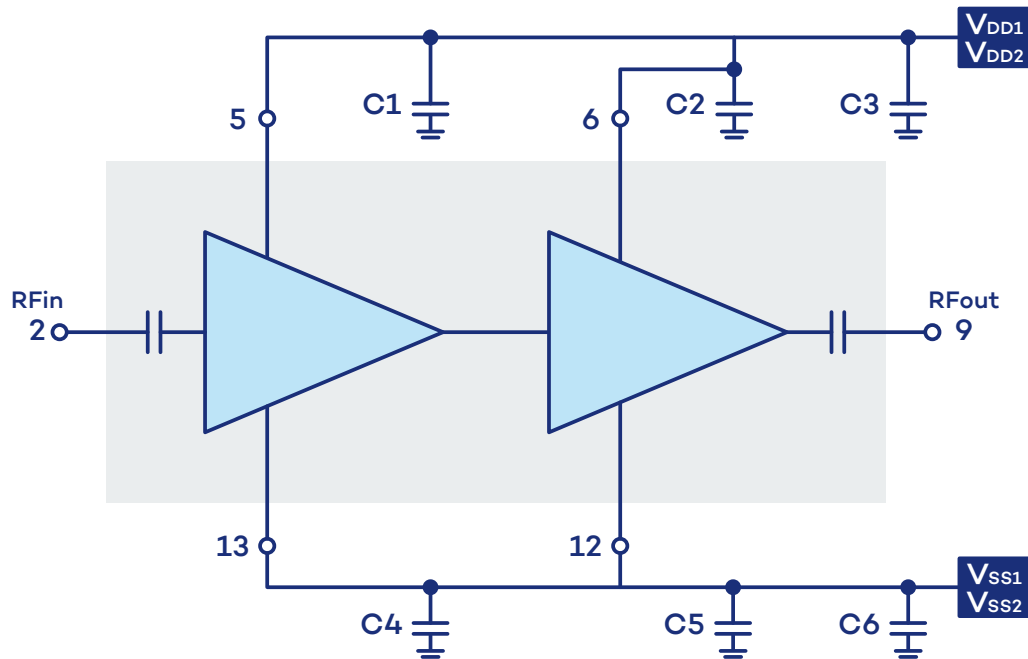
V_{DD}	V_{SS}	I_{DD}
2.0V	-3.0V	31mA
2.5V	-3.0V	28mA
3.0V	-3.0V	24mA
3.5V	-3.0V	24mA
4.0V	-3.0V	24mA

Pin description

Pin number	Name	Description	Electrical interface
2	RF in	AC coupled, amplifier input access. Internally matched 50 Ω .	
9	RF out	AC coupled amplifier output access. Internally matched 50 Ω .	
5, 6	V_{DD1} , V_{DD2}	1 st stage and 2 nd stage drain biasing access.	
13, 12	V_{SS1} , V_{SS2}	1 st stage and 2 nd stage gate biasing access.	
Die bottom	Gnd	Die Bottom must be connected to RF and DC Ground.	

• Application circuit

- C1 and C2 = 100pF MIM capacitor (close to the die)
- C3 = 1μF SMD capacitor 0402



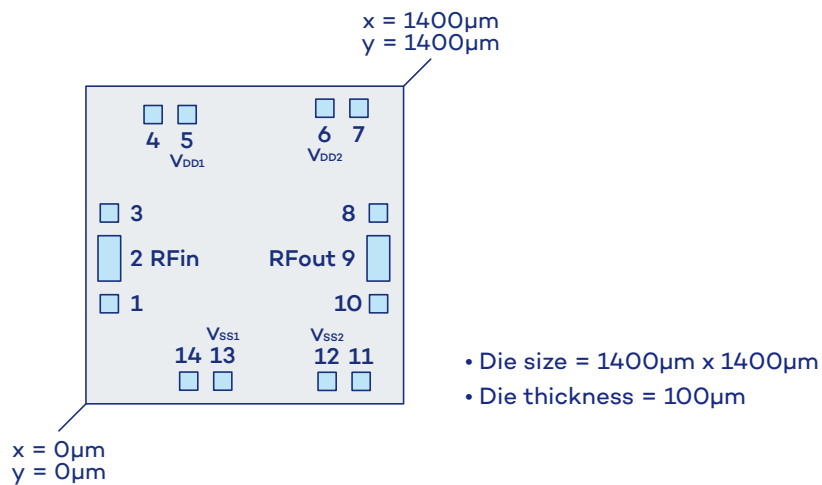
• Bias-up procedure

1. Apply V_{SS1} , $V_{SS2} = -3V$
2. Apply V_{DD1} , $V_{DD2} = +3V$
3. Turn on RF signal

• Bias-down procedure

1. Turn off RF signal
2. Reduce V_{DD1} , V_{DD2} to 0V
3. Reduce V_{SS1} , V_{SS2} to 0V

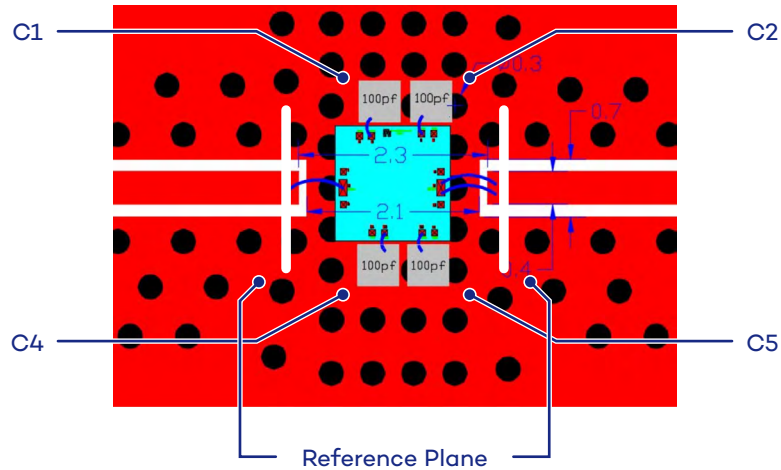
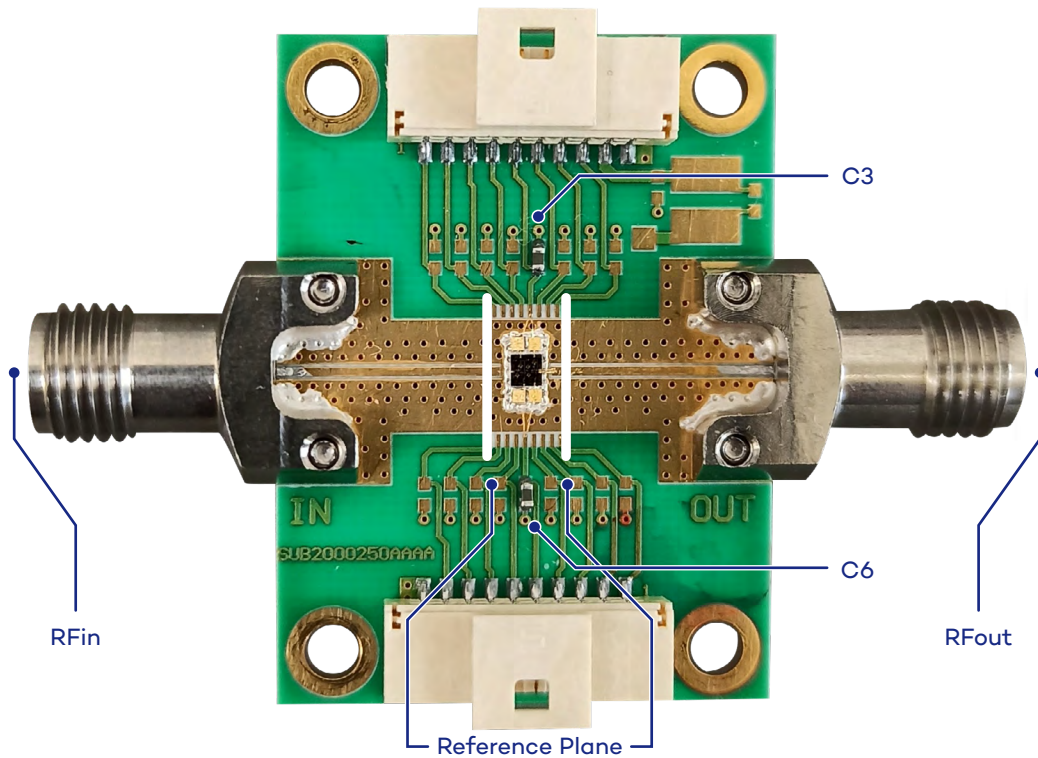
• Die Layout & Pin Out



Pad number	X (µm)	Pad center Y (µm)	Size (µm x µm)	Name	Function
1	103	441	80 x 80	Gnd	
2	103	641	100 x 200	RFin	RF Input
3	103	841	80 x 80	Gnd	
4	296	1275	80 x 80	Gnd	
5	446	1275	80 x 80	V _{DD1}	Drain Bias
6	1053	1303	80 x 80	V _{DD2}	Drain Bias
7	1203	1303	80 x 80	Gnd	
8	1289	841	80 x 80	Gnd	
9	1289	641	100 x 200	RFout	RF Output
10	1289	441	80 x 80	Gnd	
11	1213	990	80 x 80	Gnd	
12	1063	990	80 x 80	V _{SS1}	Gate Bias
13	603	1000	80 x 80	V _{SS2}	Gate Bias
14	453	1000	80 x 80	Gnd	

- Die bottom must be connected to ground (RF and DC)

• Board Layout



Substrate : RO4350B ($\epsilon_r = 3.48$), 0.254mm thickness.

Measurements on connectorized structure. Small signal gain (S21) and Noise figure are de-embedded at reference plane (see drawing above).

Note: Multiple vias should be employed under die to minimize inductance and thermal resistance.

- C1, C2, C4, C5: 100pF MIM capacitor
- RF In: 1 Gold Wire (25 μ m diameter Au)
- RF Out: 2 Gold Wires (25 μ m diameter Au each)
- C3, C6: SMD 1 μ F 0402 capacitor

• Ordering information

Product Code	Parameter
VM135D	8 to 12GHz - 18dB - 1.0dB NF Dual bias Low Noise Amplifier

• Associated Material

- Packaged die
- Die Evaluation Board (die EVB)
- Packaged die Evaluation Board (packaged die EVB)
- Mechanical files (DXF)
- Measurements files (S2P)

• Product Compliance Information

Solderability

Use only AuSn (80/20) solder and limit exposure to temperature above 300 °C during 3-4 minutes, maximum.

ESD Sensitivity Rating

Test: Human Body Model (HBM)
Std: JEDEC Standard JESD22-A114



RoHS-Compliance

This part is compliant with EU 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

Other attributes

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C15H12Br4O2) Free
- PFOS Free
- SVHC Free

• Contact information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about Vectrawave.

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